

< DIPIPM > PSS30S73F6

TRANSFER MOLDING TYPE INSULATED TYPE

OUTLINE



MAIN FUNCTION AND RATINGS

- 3 phase DC/AC inverter
- 600V / 30A (CSTBT)
- N-side IGBT open emitter
- Built-in bootstrap diodes with current limiting resistor

APPLICATION

 AC 100~240Vrms(DC voltage:400V or below) class low power motor control

INTEGRATED DRIVE, PROTECTION AND SYSTEM CONTROL FUNCTIONS

• For P-side : Drive circuit, High voltage high-speed level shifting, Control supply under-voltage (UV) protection

• For N-side : Drive circuit, Control supply under-voltage protection (UV), Short circuit protection (SC),

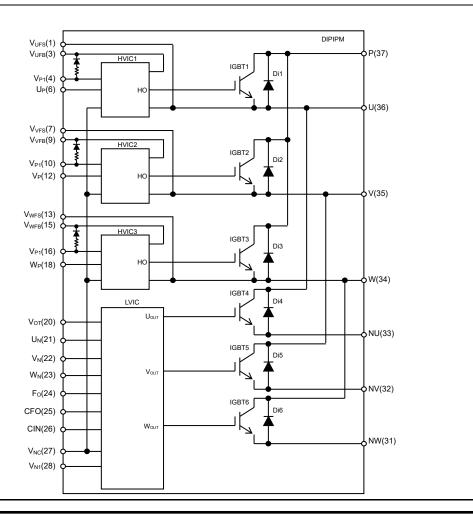
• Fault signaling : Corresponding to SC fault (N-side IGBT), UV fault (N-side supply)

• Temperature output : Outputting LVIC temperature by analog signal

• Input interface : 3, 5V line, Schmitt trigger receiver circuit (High Active)

• UL Recognized : UL1557 File E323585

INTERNAL CIRCUIT



Publication Date: January 2021

TRANSFER MOLDING TYPE **INSULATED TYPE**

MAXIMUM RATINGS (T_j = 25°C, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Condition		Ratings	Unit
V _{CC}	Supply voltage	Applied between P-NU,NV,NW	Applied between P-NU,NV,NW		V
V _{CC(surge)}	Supply voltage (surge)	Applied between P-NU,NV,NW	Applied between P-NU,NV,NW		V
V _{CES}	Collector-emitter voltage			600	V
±I _C	Each IGBT collector current	T _C = 25°C	(Note 1)	30	Α
±I _{CP}	Each IGBT collector current (peak)	T _C = 25°C, less than 1ms		60	Α
T _{jop}	Operation junction temperature	Continuous operation	(Note 2)	-30~+150	°C
T _{imax}	Maximum junction temperature	Temporally operation (e.g. overload)		175	°C

Note 1: Pulse width and period are limited due to junction temperature.

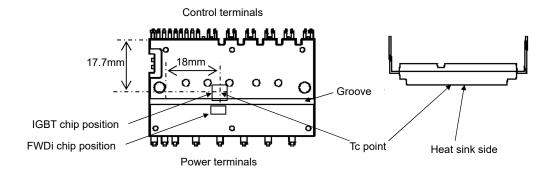
CONTROL (PROTECTION) PART

Symbol	Parameter	Condition	Ratings	Unit
V _D	Control supply voltage	Applied between V _{P1} -V _{NC} , V _{N1} -V _{NC}	20	V
V_{DB}	Control supply voltage	Applied between V _{UFB} -V _{UFS} , V _{VFB} -V _{VFS} ,V _{WFB} -V _{WFS}	20	V
V _{IN}	Input voltage	Applied between U _P , V _P , W _P -V _{PC} , U _N , V _N , W _N -V _{NC}	-0.5~V _D +0.5	V
V_{FO}	Fault output supply voltage	Applied between Fo-V _{NC}	-0.5~V _D +0.5	V
I _{FO}	Fault output current	Sink current at F ₀ terminal	1	mA
V _{SC}	Current sensing input voltage	Applied between CIN-V _{NC}	-0.5~V _D +0.5	V

TOTAL SYSTEM

Symbol	Parameter Condition		Ratings	Unit
V _{CC(PROT)}	Self protection supply voltage limit (Short circuit protection capability)			V
T _C	Module case operation temperature Measurement point of Tc is provided in Fig.1		-30~+125	°C
T _{stg}	Storage temperature		-40~+125	°C
V _{iso}	Isolation voltage	60Hz, Sinusoidal, AC 1min, between connected all pins and heat sink plate	2500	V _{rms}

Fig. 1: T_C MEASUREMENT POINT



THERMAL RESISTANCE

Symbol	Parameter	Condition	Limits			Unit
Symbol	Farameter	Condition	Min.	Тур.	Max.	Offic
$R_{th(j-c)Q}$	Junction to case thermal	Inverter IGBT part (per 1/6 module)	ı	-	1.1	K/W
R _{th(j-c)F}	resistance (Note 3)	Inverter FWDi part (per 1/6 module)	-	-	2.8	K/W

Note 3: Grease with good thermal conductivity and long-term endurance should be applied evenly with about +100µm~+200µm on the contacting surface of DIPIPM and heat sink. The contacting thermal resistance between DIPIPM case and heat sink Rth(c-f) is determined by the thickness and the thermal conductivity of the applied grease. For reference, Rth(c-f) is about 0.3K/W (per 1/6 module, grease thickness: 20µm, thermal conductivity: 1.0W/m•k).

Note 2: The maximum junction temperature rating of built-in power chips is 175°C(@Tc≤125°C). However, to ensure safe operation of DIPIPM, the average junction temperature should be limited to Tj(Ave)≤150°C (@Tc≤125°C).

TRANSFER MOLDING TYPE **INSULATED TYPE**

ELECTRICAL CHARACTERISTICS (T_i = 25°C, unless otherwise noted) **INVERTER PART**

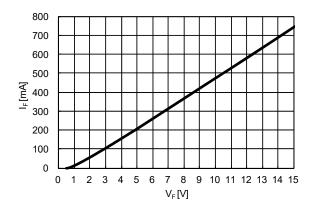
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Symbol	Parameter	Condition			Limits			
Syllibol	Farameter	Conc	Condition		Тур.	Max.	Unit	
M	Collector-emitter saturation	$V_D = V_{DB} = 15V, V_{IN} = 5V$	I _C = 30A, T _j = 25°C	-	1.35	1.65	V	
$V_{CE(sat)}$	voltage $V_D - V_{DB} - 15V$	V _D -V _{DB} - 13V, V _{IN} - 3V	I _C = 30A, T _j = 125°C	-	1.45	1.80	v	
V _{EC}	FWDi forward voltage	V _{IN} = 0V, -I _C = 30A	V _{IN} = 0V, -I _C = 30A		1.50	2.00	V	
t _{on}				0.95	1.55	2.15	μs	
$t_{C(on)}$		$V_{CC} = 300V, V_D = V_{DB} = 15V$		-	0.50	0.80	μs	
t _{off}	Switching times $I_C = 30A$, $T_j = 125$ °C, $V_{IN} = 0 \leftrightarrow 5$ \		V	-	1.75	2.35	μs	
$t_{C(off)}$		Inductive Load (upper-lower a	arm)	-	0.20	0.40	μs	
t _{rr}				-	0.30	-	μs	
1	Collector-emitter cut-off	\/ -\/	T _j = 25°C	-	-	1	mA	
ICES	current	V _{CE} =V _{CES}	T _i = 125°C	-	-	10	IIIA	

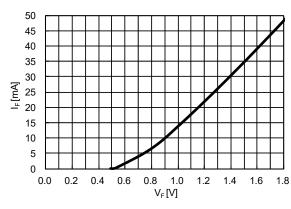
CONTROL (PROTECTION) PART

Symbol	Parameter	Con	dition		Limits		
Symbol	raiailletei	Con	allon	Min.	Тур.	Max.	Unit
		Total of V V V	Total of V V V V	-	-	6.00	
I _D	- Circuit current	Total of V_{P1} - V_{NC} , V_{N1} - V_{NC} $V_D=15V$, $V_{IN}=5V$		-	-	6.00	А
1		Each part of V_{UFB} - V_{UFS} , $V_D = V_{DB} = V_{DB}$	$V_D = V_{DB} = 15V$, $V_{IN} = 0V$	-	-	0.55	mA
I _{DB}			$V_D=V_{DB}=15V$, $V_{IN}=5V$	-	-	0.55	
$V_{SC(ref)}$	Short circuit trip level	V _D = 15V	(Note 4)	0.45	0.48	0.51	V
UV_DBt	P-side Control supply		Trip level	10.0	-	12.0	V
UV_DBr	under-voltage protection(UV)	T <105°C	Reset level	10.5	-	12.5	V
UV_Dt	N-side Control supply	T _j ≤125°C	Trip level	10.3	-	12.5	V
UV_Dr	under-voltage protection(UV)		Reset level	10.8	-	13.0	V
V _{OT}	Temperature Output	LVIC Temperature=85°C, Pull down R=5.1kΩ (Note 5)		2.51	2.64	2.76	V
V_{FOH}	Fault output voltage	$V_{SC} = 0V$, F_0 terminal pulled up to 5V by $10k\Omega$		4.9	-	-	V
V_{FOL}	Fault output voltage	V_{SC} = 1V, I_{FO} = 1mA		-	-	0.95	V
t_{FO}	Fault output pulse width	C _{FO} =22nF	(Note 6)	1.6	2.4	-	ms
I _{IN}	Input current	V _{IN} = 5V		0.70	1.00	1.50	mA
$V_{th(on)}$	ON threshold voltage			-	2.10	2.60	
$V_{th(off)}$	OFF threshold voltage	DFF threshold Applied between Op, Vp, VVp, ON, VN, VVn-VNC		0.80	1.30	-	V
$V_{\text{th(hys)}}$	ON/OFF threshold hysteresis voltage			0.35	0.80	-	
V_{F}	Bootstrap Di forward voltage	I _F =10mA including voltage drop	I _F =10mA including voltage drop by limiting resistor (Note 7)		0.9	1.3	V
R	Built-in limiting resistance	Included in bootstrap Di		16	20	24	Ω

Note 4 : SC protection works only for N-side IGBT. Please select the external shunt resistance such that the SC trip-level is less than 2.0 times of the current rating. 5 : DIPIPM don't shutdown IGBTs and output fault signal automatically when temperature rises excessively. When temperature exceeds the protective level that user defined, controller (MCU) should stop the DIPIPM. Temperature of LVIC vs. VOT output characteristics is described in Fig. 3.

Fig. 2 Characteristics of bootstrap Di V_F-I_F curve (@Ta=25°C) including voltage drop by limiting resistor (Right chart is enlarged chart.)





^{6 :} Fault signal Fo outputs when SC or UV protection works. Fo pulse width is different for each protection modes. At SC failure, Fo pulse width is a fixed width which is specified by the capacitor connected to CFO terminal. (CFO=9.1 x 10-6 x tFO [F]), but at UV failure, Fo outputs continuously until recovering from UV state. (But minimum Fo pulse width is the specified time by C_{FO}.) 7: The characteristics of bootstrap Di is described in Fig.2.

TRANSFER MOLDING TYPE

INSULATED TYPE

Fig. 3 Temperature of LVIC vs. V_{OT} output characteristics

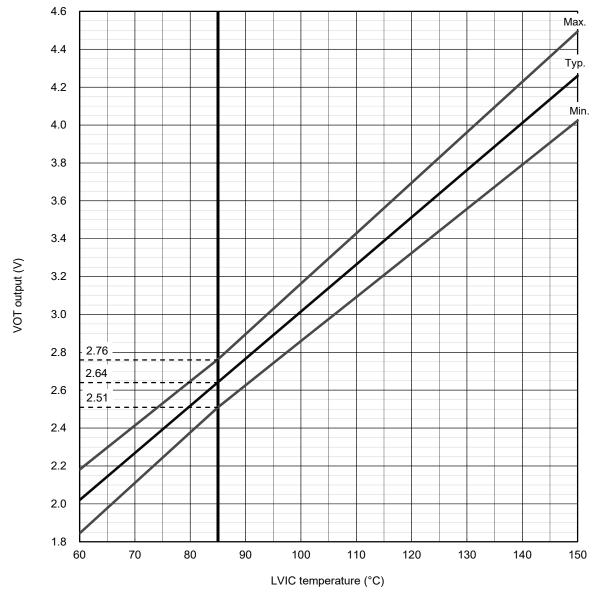
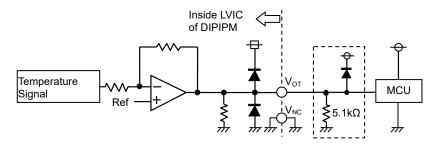


Fig. 4 VoT output circuit



- (1) It is recommended to insert $5k\Omega$ (5.1 $k\Omega$ is recommended) pull down resistor for getting linear output characteristics at low temperature below room temperature. When the pull down resistor is inserted between V_{OT} and V_{NC}(control GND), the extra circuit current, which is calculated approximately by VOT output voltage divided by pull down resistance, flows as LVIC circuit current continuously. In the case of using V_{OT} for detecting high temperature over room temperature only, it is unnecessary to insert the pull down resistor.
- (2) In the case of using VoT with low voltage controller like 3.3V MCU, VoT output might exceed control supply voltage 3.3V when temperature rises excessively. If system uses low voltage controller, it is recommended to insert a clamp Di between control supply of the controller and V_{OT} output for preventing over voltage destruction. (3) In the case of not using V_{OT} , leave V_{OT} output NC (No Connection).

Refer the application note for this product about the usage of V_{OT}.

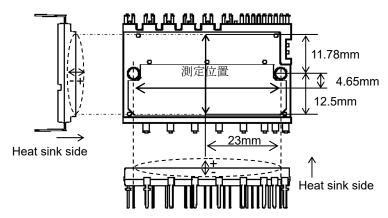
TRANSFER MOLDING TYPE INSULATED TYPE

MECHANICAL CHARACTERISTICS AND RATINGS

Parameter	Condition		Standard		Limits		Unit
Falametei	Condition		Standard	Min.	Тур.	Max.	Offic
Manuation tangua	Manustina assess M2	(11 1 0)	JEITA-ED-4701	0.50	0.70	0.00	NI
Mounting torque	Mounting screw : M3	(Note 8)	402 Method II	0.59	0.78	0.98	N·m
Tamain along the matter	Land 40M		JEITA-ED-4701	40			_
Terminal pulling strength	Load 10N		401 Method I	10	-	-	S
	1 15N 001 B		JEITA-ED-4701				
Terminal bending strength	Load 5N, 90deg. Bend		401 Method III	2	-	-	times
Weight			-	-	21	-	g
Heat-sink flatness		(Note 9)	-	-50	-	100	μm

Note 8: Plain washers (ISO 7089~7094) are recommended.

Note 9: Measurement point of heat sink flatness

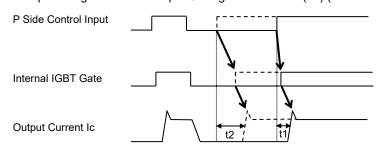


RECOMMENDED OPERATION CONDITIONS

Cumbal	Deremeter	Condition		Limits		Unit
Symbol	Parameter	Condition	Min.	Тур.	Max.	Unit
V _{cc}	Supply voltage	Applied between P-NU, NV, NW	0	300	400	V
V_D	Control supply voltage	Applied between V _{P1} -V _{NC} , V _{N1} -V _{NC}	13.5	15.0	16.5	V
V_{DB}	Control supply voltage	Applied between V _{UFB} -V _{UFS} , V _{VFB} -V _{VFS} , V _{WFB} -V _{WFS}		15.0	18.5	V
ΔV_D , ΔV_{DB}	Control supply variation			-	+1	V/µs
t _{dead}	Arm shoot-through blocking time	For each input signal	1.5	-	-	μs
f _{PWM}	PWM input frequency	$T_C \le 125^{\circ}C, T_j \le 150^{\circ}C$	-	-	20	kHz
PWIN(on)	Minimum input pulse width	(Note 10)	0.7	-	-	ше
PWIN(off)	williman input puise width	(Note 10)	1.5	-	-	μs
V_{NC}	V _{NC} variation	Between V _{NC} -NU, NV, NW (including surge)	-5.0	-	+5.0	V

Note 10: DIPIPM might not make response if the input signal pulse width is less than PWIN(on) / PWIN(off). Moreover, if it makes response to shorter turning off signal than PWIN(off), DIPIPM might make delayed response in case of rated current or more. Please refer below about delayed response.

Delayed Response against Shorter Input Off Signal than PWIN(off) (P-side only, above rated current)



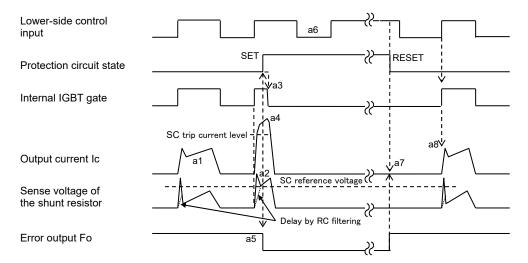
Real line: off pulse width > PWIN(off); turn on time t1 Broken line: off pulse width < PWIN(off); turn on time t2 (t1:Normal switching time)

TRANSFER MOLDING TYPE INSULATED TYPE

Fig. 5 Timing Charts of The DIPIPM Protective Functions

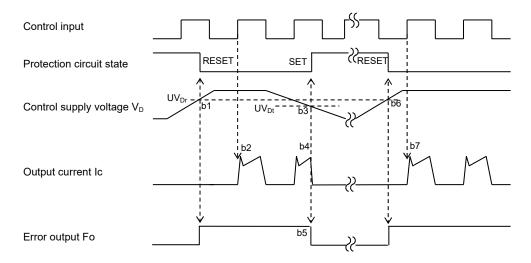
[A] Short-Circuit Protection (N-side only with the external shunt resistor and RC filter)

- a1. Normal operation: IGBT ON and outputs current.
- a2. Short circuit current detection (SC trigger)
 - (It is recommended to set RC time constant 1.5~2.0µs so that IGBT shut down within 2.0µs when SC.)
- a3. All N-side IGBT's gates are hard interrupted.
- a4. All N-side IGBTs turn OFF.
- a5. F_0 outputs. The pulse width of the Fo signal is set by the external capacitor C_{FO} .
- a6. Input = "L": IGBT OFF
- a7. Fo finishes output, but IGBTs don't turn on until inputting next ON signal (L→H).
 - (IGBT of each phase can return to normal state by inputting ON signal to each phase.)
- a8. Normal operation: IGBT ON and outputs current.



[B] Under-Voltage Protection (N-side, UV_D)

- b1. Control supply voltage V_D exceeds under voltage reset level (UV_{Dr}), but IGBT turns ON by next ON signal (L→H). (IGBT of each phase can return to normal state by inputting ON signal to each phase.)
- b2. Normal operation: IGBT ON and outputs current.
- b3. V_D level drops to under voltage trip level. (UV $_{Dt}$).
- b4. All N-side IGBTs turn OFF in spite of control input condition.
- b5. Fo outputs for the period set by the capacitance C_{FO} but output is extended during V_D keeps below UV_{Dr} .
- b6. V_D level reaches UV_{Dr}.
- b7. Normal operation: IGBT ON and outputs current.



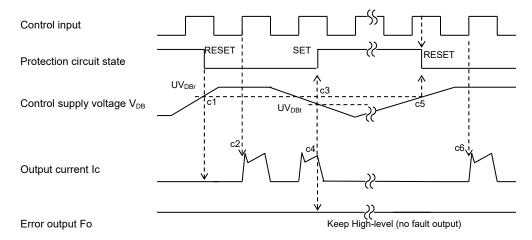
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TRANSFER MOLDING TYPE INSULATED TYPE

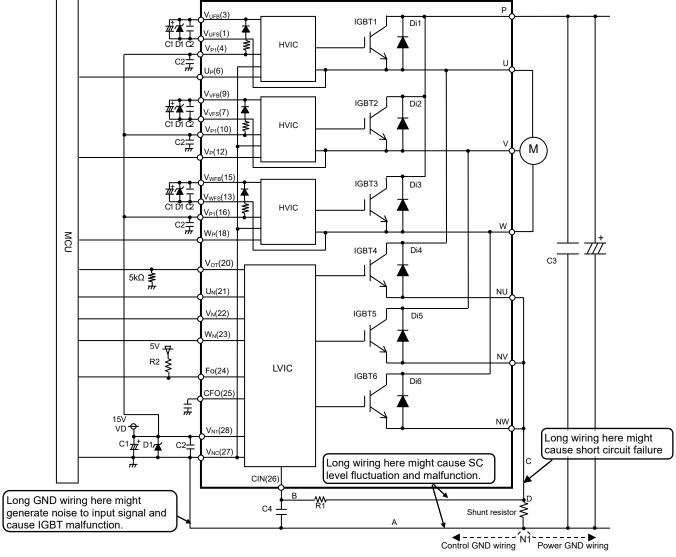
[C] Under-Voltage Protection (P-side, UVDB)

- c1. Control supply voltage V_{DB} rises. After the voltage reaches under voltage reset level UV_{DBr}, IGBT turns on by next ON signal (L→H).
- c2. Normal operation: IGBT ON and outputs current.
- c3. V_{DB} level drops to under voltage trip level (UV_{DBt}).
- c4. IGBT of the correspond phase only turns OFF in spite of control input signal level, but there is no Fo signal output.
- c5. V_{DB} level reaches UV_{DBr}.
- c6. Normal operation: IGBT ON and outputs current.



TRANSFER MOLDING TYPE INSULATED TYPE

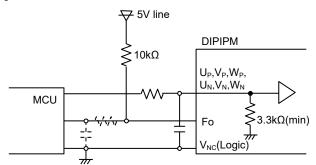
Fig. 6 Example of Application Circuit



- (1) If control GND is connected with power GND by common broad pattern, it may cause malfunction by power GND fluctuation. It is recommended to connect control GND and power GND at only a point N1 (near the terminal of shunt resistor).
- (2) It is recommended to insert a Zener diode D1(24V/1W) between each pair of control supply terminals to prevent surge destruction.
- (3) To prevent surge destruction, the wiring between the smoothing capacitor and the P, N1 terminals should be as short as possible. Generally a 0.1-0.22µF snubber capacitor C3 between the P-N1 terminals is recommended.
- (4) R1, C4 of RC filter for preventing protection circuit malfunction is recommended to select tight tolerance, temp-compensated type. The time constant R1C4 should be set so that SC current is shut down within 2µs. (1.5µs~2µs is recommended generally.) SC interrupting time might vary with the wiring pattern, so the enough evaluation on the real system is necessary.
- (5) To prevent malfunction, the wiring of A, B, C should be as short as possible.
- (6) The point D at which the wiring to CIN filter is divided should be near the terminal of shunt resistor. NU, NV, NW terminals should be connected at near NU, NV, NW terminals when it is used by one shunt operation. Low inductance SMD type with tight tolerance, temp-compensated type is recommended for shunt resistor.
- (7) All capacitors should be mounted as close to the terminals as possible. (C1: good temperature, frequency characteristic electrolytic type and C2:0.22μ-2μF, good temperature, frequency and DC bias characteristic ceramic type are recommended.)
- (8) Input logic is High-active. There is a 3.3kΩ(min.) pull-down resistor in the input circuit of IC. To prevent malfunction, the input wiring should be as short as possible. When using RC coupling, make the input signal level meet the turn-on and turn-off threshold voltage.
- (9) Fo output is open drain type. It should be pulled up to power supply of MCU (e.g. 5V,3.3V) by a resistor that makes I_{Fo} up to 1mA. (I_{FO} is estimated roughly by the formula of control power supply voltage divided by pull-up resistance. In the case of pulled up to 5V, 10kΩ (5kΩ or more) is recommended.) When using opto coupler, Fo also can be pulled up to 15V (control supply of DIPIPM) by the resistor.
- (10) Fo pulse width can be set by the capacitor connected to CFO terminal. $C_{FO}(F) = 9.1 \times 10^{-6} \times t_{FO}$ (Required Fo pulse width).
- (11) If high frequency noise superimposed to the control supply line, IC malfunction might happen and cause DIPIPM erroneous operation. To avoid such problem, line ripple voltage should meet dV/dt ≤+/-1V/μs, Vripple≤2Vp-p.
- (12) For DIPIPM, it isn't recommended to drive same load by parallel connection with other phase IGBT or other DIPIPM.

TRANSFER MOLDING TYPE INSULATED TYPE

Fig. 7 MCU I/O Interface Circuit



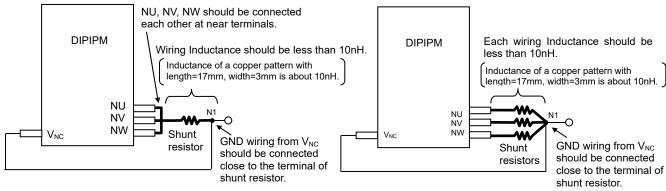
Note)

Design for input RC filter depends on PWM control scheme used in the application and wiring impedance of the printed circuit board.

DIPIPM input signal interface integrates a minimum $3.3 k\Omega$ pull-down resistor. Therefore, when inserting RC filter, it is necessary to satisfy turn-on threshold voltage requirement.

Fo output is open drain type. It should be pulled up to control power supply (e.g. 5V, 15V) with a resistor that makes Fo sink current I_{Fo} 1mA or less. In the case of pulled up to 5V supply, $10k\Omega(5k\Omega$ or more) is recommended.

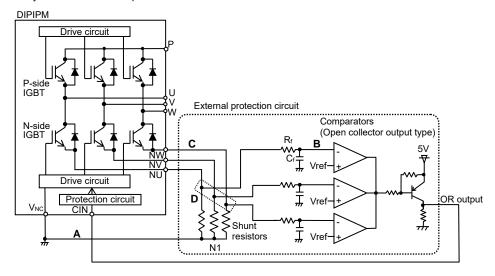
Fig. 8 Pattern Wiring Around the Shunt Resistor



Low inductance shunt resistor like surface mounted (SMD) type is recommended.

Fig. 9 Pattern Wiring Around the Shunt Resistor (for the case of open emitter)

When DIPIPM is operated with three shunt resistors, voltage of each shunt resistor cannot be input to CIN terminal directly. In that case, it is necessary to use the external protection circuit as below.



- (1) It is necessary to set the time constant R_fC_f of external comparator input so that IGBT stops within 2µs when short circuit occurs. SC interrupting time might vary with the wiring pattern, comparator speed and so on.
- (2) It is recommended for the threshold voltage Vref to set to the same rating of short circuit trip level (Vsc(ref): typ. 0.48V).
- (3) Select the external shunt resistance so that SC trip-level is less than specified value (=2.0 times of rating current).
- (4) To avoid malfunction, the wiring A, B, C should be as short as possible.
- (5) The point D at which the wiring to comparator is divided should be close to the terminal of shunt resistor.
- (6) OR output high level when protection works should be over 0.51V (=maximum Vsc(ref) rating).
- (7) GND of Comparator, GND of Vref circuit and Cf should be not connected to power GND but to control GND wiring.

TRANSFER MOLDING TYPE

INSULATED TYPE Fig. 10 Package Outlines Dimensions in mm TERMINAL CODE SIDE DETAIL SINK (.5~ -0) 0.6) (8.2) Terminal of () is the dummy terminal for internal use. This terminal should be kept NC (no connection). (87.21) DETAIL D 0.5 (dr.1) 7.71 7.71 6.0± 6,6δ (ø3.7) Ø3.3 2.04±0.3 0 5. 38 1 7,62±0.3 Lot No. 2D CODE \bigcirc $A=1.78\pm0.2$, $B=4.32\pm0.2$ 36 name, 52,5 0 \bigcirc 35 Туре 34 (11×1.78) \bigcirc 1.78±0.2 33 32 - 🕩 O_E č.0± ľ.√ (2.2)

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Publication Date: January 2021

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